Notice of References Cited Application/Control No. 10/667,004 Examiner FRANK W. LU 1634 Applicant(s)/Patent Under Reexamination CHAN ET AL. Page 1 of 1 U.S. PATENT DOCUMENTS

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*	Α	US-2002/0146714 A1	10-2002	Lieber et al.	435/6
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